F2HALFBR Module

Product Preview

NXH006P120MNF2PTG

The NXH006P120MNF2 is a power module containing an 6 m Ω /1200 V SiC MOSFET half-bridge and a thermistor in an F2 package.

Features

- 6 mΩ /1200 V SiC MOSFET Half-bridge
- Thermistor
- Options with Pre-applied Thermal Interface Material (TIM) and without Pre-applied TIM
- Options with Solderable Pins and Press-fit Pins
- These Devices are Pb-Free, Halide Free and are RoHS Compliant

Typical Applications

- Solar Inverter
- Uninterruptible Power Supplies
- Electric Vehicle Charging Stations
- Industrial Power

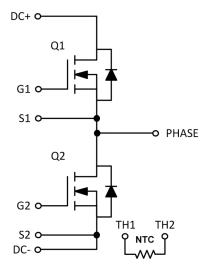


Figure 1. NXH006P120MNF2 Schematic Diagram

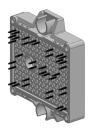
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PACKAGE PICTURE

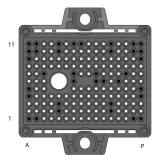


PIM36 56.7x42.5 (PRESS FIT) CASE 180BY

MARKING DIAGRAM

XXXXX = Specific Device Code
AT = Assembly & Test Site Code
YWW = Year and Work Week Code

PIN CONNECTIONS



See Pin Function Description for pin names

ORDERING INFORMATION

See detailed ordering and shipping information on page 4 of this data sheet.

PIN FUNCTION DESCRIPTION

Pin	Name	Description	
A1	S1	Q1 Kelvin Emitter (High side switch)	
A4	DC+	DC Positive Bus connection	
A5	DC+	DC Positive Bus connection	
A9	PHASE	Center point of half bridge	
A10	PHASE	Center point of half bridge	
A11	PHASE	Center point of half bridge	
B1	G1	Q1 Gate (High side switch)	
B10	PHASE	Center point of half bridge	
B11	PHASE	Center point of half bridge	
C7	DC-	DC Negative Bus connection	
E2	DC+	DC Positive Bus connection	
E3	DC+	DC Positive Bus connection	
E10	S2	Q2 Kelvin Emitter (Low side switch)	
E11	G2	Q2 Gate (Low side switch)	
G6	DC-	DC Negative Bus connection	
G7	DC-	DC Negative Bus connection	
G11	TH1	Thermistor Connection 1	
H11	TH2	Thermistor Connection 2	
J6	DC-	DC Negative Bus connection	
J7	DC-	DC Negative Bus connection	
K6	DC-	DC Negative Bus connection	
L2	DC+	DC Positive Bus connection	
L3	DC+	DC Positive Bus connection	
L10	S2	Q2 Kelvin Emitter (Low side switch)	
L11	G2	Q2 Gate (Low side switch)	
M6	DC-	DC Negative Bus connection	
N7	DC-	DC Negative Bus connection	
01	G1	Q1 Gate (High side switch)	
O10	PHASE	Center point of half bridge	
O11	PHASE	Center point of half bridge	
P1	S1	Q1 Kelvin Emitter (High side switch)	
P4	DC+	DC Positive Bus connection	
P5	DC+	DC Positive Bus connection	
P9	PHASE	Center point of half bridge	
P10	PHASE	Center point of half bridge	
P11	PHASE	Center point of half bridge	

MAXIMUM RATINGS

Rating	Symbol	Value	Unit
SIC MOSFET			
Drain-Source Voltage	V _{DSS}	1200	V
Gate-Source Voltage	V _{GS}	+25/–15	V
Continuous Drain Current @ T _c = 80°C (T _J = 175°C)	I _D	304	А
Pulsed Drain Current (T _J = 175°C)	I _{Dpulse}	912	А
Maximum Power Dissipation (T _J = 175°C)	P _{tot}	950	W
Short Circuit Withstand Time @ V_{GE} = 15 V, V_{CE} = 600 V, $T_{J} \le 150^{\circ}C$	T _{sc}	2.0	μs
Minimum Operating Junction Temperature	T _{JMIN}	-40	°C
Maximum Operating Junction Temperature	T _{JMAX}	175	°C
THERMAL PROPERTIES			
Storage Temperature range	T _{stg}	-40 to 150	°C
INSULATION PROPERTIES	·		
Isolation test voltage, t = 1 sec, 60 Hz	V _{is}	3000	V_{RMS}
Creepage distance		12.7	mm

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

RECOMMENDED OPERATING RANGES

Rating	Symbol	Min	Max	Unit
Module Operating Junction Temperature	TJ	-40	175	°C

Functional operation above the stresses listed in the Recommended Operating Ranges is not implied. Extended exposure to stresses beyond the Recommended Operating Ranges limits may affect device reliability.

ELECTRICAL CHARACTERISTICS

 T_J = 25 $^{\circ}C$ unless otherwise noted

Parameter	Test Conditions	Symbol	Min	Тур	Max	Unit
SIC MOSFET CHARACTERISTICS						
Drain–Source Breakdown Voltage $V_{GS} = 0 \text{ V}, I_D = 800 \mu\text{A}$		V _{(BR)DSS}	1200	_	-	V
Zero Gate Voltage Drain Current	V _{GS} = 0 V, V _{DS} = 1200 V	I _{DSS}	-	-	300	μΑ
Drain-Source On Resistance	V_{GS} = 20 V, I_D = 200 A, T_J = 25 °C	R _{DS(ON)}	-	5.48	7.2	mΩ
	V_{GS} = 20 V, I_D = 200 A, T_J = 125 °C		-	6.52	-	
	V_{GS} = 20 V, I_{D} = 200 A, T_{J} = 150 °C		_	7.28	_	
Gate-Source Threshold Voltage	$V_{GS} = V_{DS}$, $I_D = 80 \text{ mA}$	V _{GS(TH)}	1.8	2.83	4.3	V
Gate Leakage Current	V _{GS} = -10 V / 20 V, V _{DS} = 0 V	I _{GSS}	-1000	-	1000	nA
Forward Transconductance	V _{DS} = 10 V, I _D = 200 A	9 _{FS}		14		S
Internal Gate Resistance		R _G		-		Ω
Input Capacitance		C _{ISS}	_	6687	_	pF
Reverse Transfer Capacitance	V _{DS} = 800 V. V _{GS} = 0 V. f = 1 MHz	C _{RSS}	-	49	=	
Output Capacitance		Coss	_	1092	_	
C _{OSS} Stored Energy	V _{DS} = 0 V to 800 V. V _{GS} = 0 V.	Eoss	_	349	_	μJ
Total Gate Charge	V _{DS} = 800 V. V _{GS} = 20 V. I _D = 200 A	Q _{G(TOTAL)}	-	847	=	nC
Gate-Source Charge		Q _{GS}	_	231	_	nC
Gate-Drain Charge		Q_{GD}	-	195	_	nC

^{1.} Refer to ELECTRICAL CHĂRACTERISTICS, RECOMMENDED OPERATING RANGES and/or APPLICATION INFORMATION for Safe Operating parameters.

ELECTRICAL CHARACTERISTICS (continued)

 T_J = 25 $^{\circ}C$ unless otherwise noted

Parameter	Test Conditions	Symbol	Min	Тур	Max	Unit
SIC MOSFET CHARACTERISTICS						
Turn-on Delay Time		t _{d(on)}	_	54	_	ns
Rise Time	$T_J = 25^{\circ}C$	t _r	-	21	-	
Turn-off Delay Time	V_{DS} = 600 V, I_D = 200 A V_{GS} = -5 V / 20 V, R_G = 1.8 Ω	t _{d(off)}	_	174	_	
Fall Time	VGS = 0 V / 20 V, FIG = 1.0 II	t _f	_	22	-	
Turn-on Switching Loss per Pulse		E _{ON}	_	2.1	_	mJ
Turn off Switching Loss per Pulse		E _{OFF}	_	2.75	_	
Turn-on Delay Time		t _{d(on)}	_	48	_	ns
Rise Time	$T_{\rm J} = 150^{\circ}{\rm C}$	t _r	_	19	_	
Turn-off Delay Time	$V_{DS} = 600 \text{ V}, I_D = 200 \text{ A}$ $V_{GS} = -5 \text{ V} / 20 \text{ V}, R_G = 1.8 \Omega$	t _{d(off)}	_	196	_	
Fall Time		t _f	_	22	-	
Turn-on Switching Loss per Pulse		E _{ON}	_	2.3	_	mJ
Turn off Switching Loss per Pulse	7	E _{OFF}	-	2.93	-	
Diode Forward Voltage	I _D = 200 A, T _J = 25 °C	V _{SD}	_	4.0	6	V
	I _D = 200 A, T _J = 150 °C		_	3.6	_	
Thermal Resistance - chip-to-case	Thermal grease,	R _{thJC}	=	0.10	=	°C/W
Thermal Resistance - chip-to-heatsink	Thickness = 2 Mil +2%, A = 2.8 W/mK	R _{thJH}	-	0.21	_	°C/W
THERMISTOR CHARACTERISTICS						
Nominal resistance	T = 25°C	R ₂₅	_	5	_	kΩ
Nominal resistance	T = 100°C	R ₁₀₀	_	457	-	Ω
Deviation of R25		ΔR/R	-3	_	3	%
Power dissipation		P _D	_	50	_	mW
Power dissipation constant			_	5	-	mW/K
B-value	B(25/50), tolerance ±3%		-	3375	_	K
B-value	B(25/100), tolerance ±3%		=	3455	=	K

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

ORDERING INFORMATION

Orderable Part Number	Marking	Package	Shipping
NXH006P120MNF2PTG	NXH006P120MNF2PTG	F2HALFBR: Case 180BY Press-fit Pins with pre-applied thermal interface material (TIM) (Pb-Free / Halide Free)	20 Units / Blister Tray

TYPICAL CHARACTERISTICS

HALFBRIDGE MOSFET

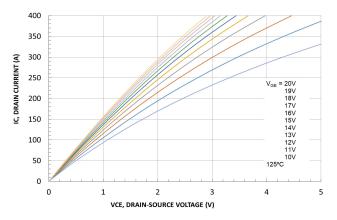


Figure 2. MOSFET Typical Output Characteristic at 125°C

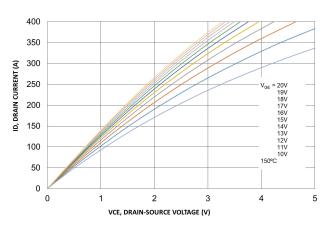


Figure 4. MOSFET Typical Output Characteristic

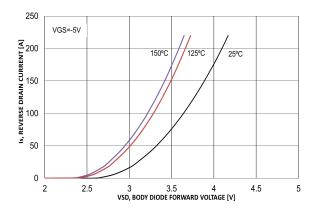


Figure 6. Body Diode Forward Characteristic

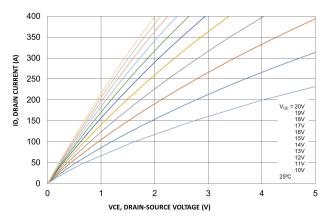


Figure 3. MOSFET Typical Output Characteristic

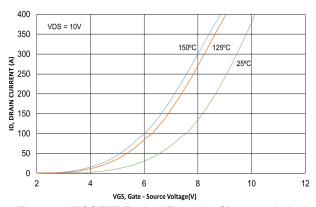


Figure 5. MOSFET Typical Transfer Characteristic

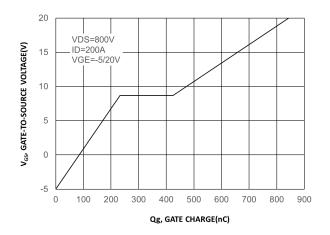


Figure 7. Gate-to-Source Voltage vs. Total Charge

TYPICAL CHARACTERISTICS

(25°C unless otherwise noted)

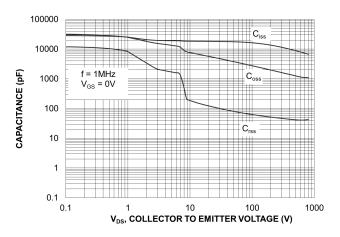


Figure 8. Capacitance vs. Drain-to-Source Voltage

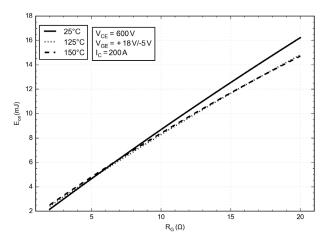


Figure 10. Typical Switching Loss Eon vs. Rg

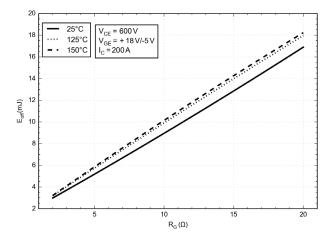


Figure 12. Typical Switching Loss Eoff vs. Rg

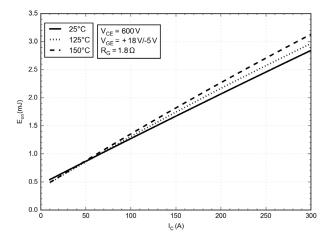


Figure 9. Typical Switching Loss Eon vs. IC

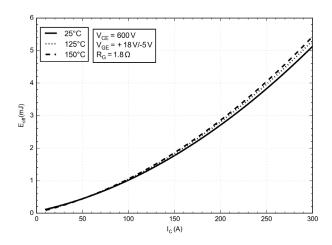


Figure 11. Typical Switching Loss Eoff vs. IC

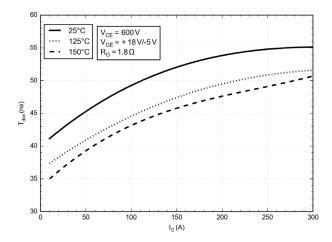


Figure 13. Typical Switching Loss Tdon vs. IC

TYPICAL CHARACTERISTICS

(25°C unless otherwise noted)

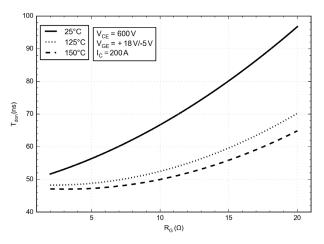


Figure 14. Typical Switching Loss Tdon vs. Rg

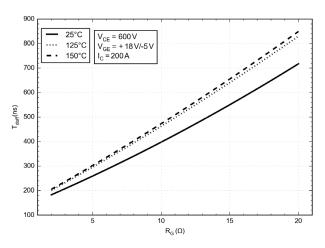


Figure 16. Typical Switching Loss Tdoff vs. Rg

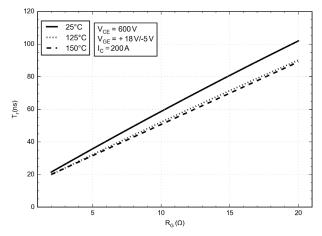


Figure 18. Typical Switching Loss Tr vs. Rg

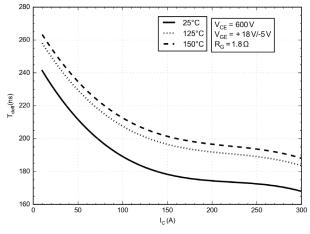


Figure 15. Typical Switching Loss Tdoff vs. IC

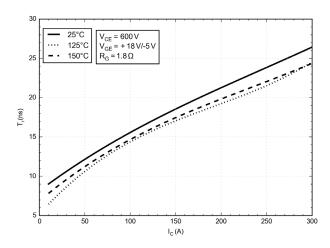


Figure 17. Typical Switching Loss Tr vs. IC

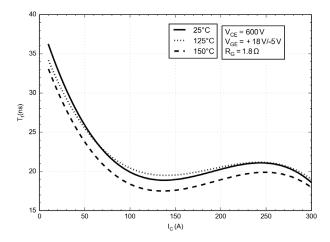


Figure 19. Typical Switching Loss Tf vs. IC

TYPICAL CHARACTERISTICS

(25°C unless otherwise noted)

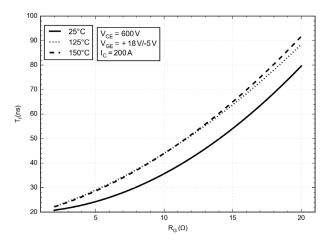


Figure 20. Typical Switching Loss Tf vs. Rg

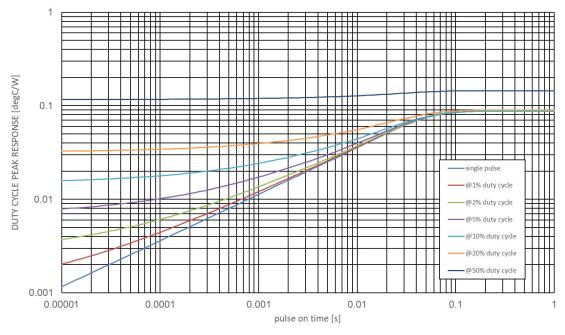


Figure 21. MOSFET Junction-to-Case Transient Thermal Impedance

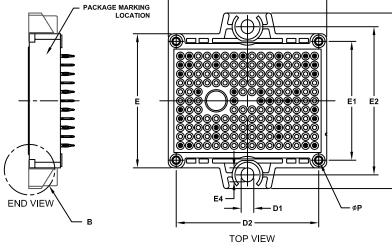


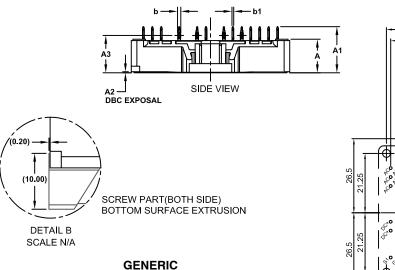
DATE 28 JAN 2021

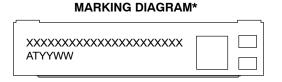
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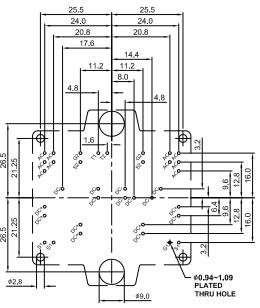
- 1. CONTROLLING DIMENSION: MILLIMETERS
- 2. PIN POSITION TOLERANCE IS ± 0.4mm

	MILLIMETERS			
DIM	MIN.	NOM.	MAX.	
Α	11.65	12.00	12.35	
A 1	16.00	16.50	17.00	
A2	0.00	0.35	0.60	
А3	12.85	13.35	13.85	
b	1.15	1.20	1.25	
b1	0.59	0.64	0.69	
D	56.40	56.70	57.00	
D1	4.40	4.50	4.60	
D2	50.85	51.00	51.15	
E	47.70	48.00	48.30	
E1	42.35	42.50	42.65	
E2	52.90	53.00	53.10	
E3	62.30	62.80	63.30	
E4	4.90	5.00	5.10	
Р	2,20	2.30	2.40	









RECOMMENDED MOUNTING PATTERN

XXXXX = Specific Device Code AT = Assembly & Test Site Code

YYWW = Year and Work Week Code

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot" ", may or may not be present. Some products may not follow the Generic Marking.

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DESCRIPTION:	PIM36 56.7x42.5 (PRESS FIT)		PAGE 1 OF 1		

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